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**CAPACITORS, FIXED, CHIPS,  
CERAMIC DIELECTRIC, TYPE II,  
BASED ON TYPE 1812  
ESA/SCC Detail Specification No. 3009/010**



**space components  
coordination group**

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**SCC**

ESA/SCC Detail Specification  
No. 3009/010

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**DOCUMENTATION CHANGE NOTICE**

Rev. Letter	Rev. Date	Reference	CHANGE Item	Approved DCR No.
		This Issue supersedes Issue 6 and incorporates all modifications defined in Revisions 'A' , 'B', 'C' and 'D' to Issue 6 and the following DCR's:- Cover page DCN Table 3	: In Test Conditions column, "U <sub>e</sub> " changed to V <sub>T</sub> in four places	None None 23943

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**1. GENERAL****1.1 SCOPE**

This specification details the ratings, physical and electrical characteristics, test and inspection data for Capacitors, Fixed, Chips, Ceramic Dielectric, Type II, based on Type 1812. It shall be read in conjunction with ESA/SCC Generic Specification No. 3009, the requirements of which are supplemented herein.

**1.2 RANGE OF COMPONENTS**

The range of capacitors covered by this specification is given in Table 1(a).

**1.3 MAXIMUM RATINGS**

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the capacitors specified herein, are as scheduled in Table 1(b).

**1.4 PARAMETER DERATING INFORMATION (FIGURE 1)**

Not applicable.

**1.5 PHYSICAL DIMENSIONS**

The physical dimensions of the capacitors specified herein are shown in Figure 2.

**1.6 FUNCTIONAL DIAGRAM**

The functional diagram for the capacitors specified herein is shown in Figure 3.



**TABLE 1(a) - RANGE OF COMPONENTS**

CAPACITANCE RANGE (pF)	TOLERANCE ( $\pm$ ) (%)	VALUES SERIES	RATED VOLTAGE ( $U_R$ ) (V)
3300 to 10000	5.0	E 24	400
3300 to 10000	10	E 12	400
3300 to 10000	20	E 6	400
3300 to 39000	5.0	E 24	200
3300 to 39000	10	E 12	200
3300 to 47000	20	E 6	200
2700 to 270000	5.0	E 24	100
2700 to 270000	10	E 12	100
3300 to 330000	20	E 6	100
47000 to 470000	5.0	E 24	50
47000 to 470000	10	E 12	50
47000 to 470000	20	E 6	50
47000 to 1000000	5.0	E 24	25
47000 to 1000000	10	E 12	25
47000 to 1000000	20	E 6	25

**NOTES**

1. As specified in Para. 4.4.1 and Figure 2, these ranges are available in 6 variants.



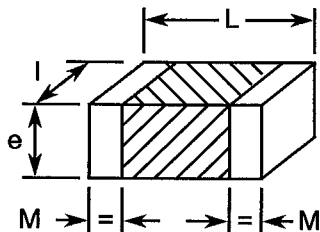
**TABLE 1(b) - MAXIMUM RATINGS**

No.	CHARACTERISTICS	SYMBOL	LIMITS		UNIT	REMARKS
			MIN.	MAX.		
1	Rated Voltage	$U_R$	See Table 1(a)		V	-
2	Operating Temperature Range	$T_{amb}$	-55	+125	°C	Without derating
3	Storage Temperature Range	$T_{stg}$	-55	+125	°C	-
4	Maximum Soldering Temperature	$T_{sol}$	-	+260	°C	Soldering time: t: <10 sec.

**FIGURE 1 - PARAMETER DERATING INFORMATION**

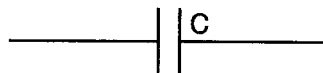
Not applicable.

**FIGURE 2 - PHYSICAL DIMENSIONS**



SYMBOL	DIMENSIONS (mm)			
	VARIANTS 01, 03, 06		VARIANTS 02, 04, 05	
	MIN.	MAX.	MIN.	MAX.
L	4.0	5.0	4.0	5.5
l	2.8	3.6	2.8	4.1
e	-	2.3	-	2.3
M	0.1	0.75	0.1	0.75

**FIGURE 3 - FUNCTIONAL DIAGRAM**



**2. APPLICABLE DOCUMENTS**

The following documents form part of this specification and shall be read in conjunction with it:-

- (a) ESA/SCC Generic Specification No. 3009 for Capacitors, Fixed, Chips, Ceramic Dielectric, Types I and II.

**3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS**

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply. In addition, the following symbols are used:-

- TCC = Temperature Characteristic.  
V<sub>T</sub> = Test Voltage.

**4. REQUIREMENTS****4.1 GENERAL**

The complete requirements for procurement of the capacitors specified herein shall be as stated in this specification and ESA/SCC Generic Specification No. 3009 for Capacitors, Fixed, Chips, Ceramic Dielectric, Types I and II. Deviations from the Generic Specification, applicable to this specification only, are listed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

**4.2 DEVIATIONS FROM GENERIC SPECIFICATION****4.2.1 Deviations from Special In-process Controls**

None.

**4.2.2 Deviations from Final Production Tests (Chart II)**

None.

**4.2.3 Deviations from Burn-in and Electrical Measurements (Chart III)**

None.

**4.2.4 Deviations from Qualification Tests (Chart IV)**

None.

**4.2.5 Deviations from Lot Acceptance Tests (Chart V)**

None.

**4.3 MECHANICAL REQUIREMENTS****4.3.1 Dimension Check**

The dimensions of the capacitors specified herein shall be verified in accordance with the requirements set out in Para. 9.3 of ESA/SCC Generic Specification No. 3009 and shall conform to those shown in Figure 2 of this specification.





4.3.2 Weight

The maximum weight of the capacitors specified herein shall be 0.2 grammes.

4.3.3 Adhesion

The requirements for adhesion are specified in Para. 9.5 of ESA/SCC Generic Specification No. 3009.

4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the capacitors specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

4.4.1 Terminations

- Variant 01: The capacitors shall be terminated with AgPd pads.
- Variant 02: The capacitors shall be terminated with AgPd with solder coating, 62 Sn, 36 Pb, 2.0 Ag %, + 188°C.
- Variant 03: The capacitors shall be terminated with AgPdPt pads.
- Variant 04: The capacitors shall be terminated with AgPdPt with solder coating, 62 Sn, 36 Pb, 2.0 Ag %, + 188°C.
- Variant 05: The capacitors shall be terminated with Ag, Ni barrier with solder coating, 62 Sn, 36Pb, 2.0 Ag %, + 188°C.
- Variant 06: The capacitors shall be terminated with Ag, Ni barrier with coating tin-lead, near eutectic, minimum 10% lead.

All the above Variants are suitable for reflow soldering.

**N.B.**

Variant 06 is the preferred termination finish for the specified chip size (see Figure 2).

4.5 MARKING

4.5.1 General

The marking of all components delivered to this specification shall be in accordance with the requirements of ESA/SCC Basic Specification No. 21700 and the following paragraphs.

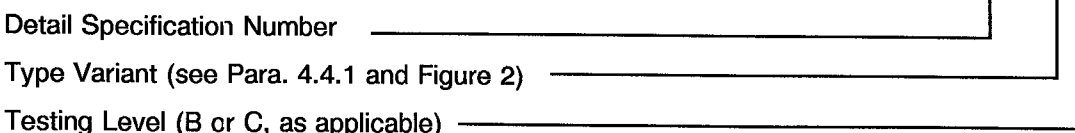
These components being too small to accommodate the marking as specified hereafter, the marking information in full shall accompany each component in its primary package. Such marking shall comprise:-

- (a) The SCC Component Number.
- (b) Characteristics and Ratings.
- (c) Traceability Information.

4.5.2 The SCC Component Number

Each component shall bear the SCC Component Number which shall be constituted and marked as follows:

300901001B



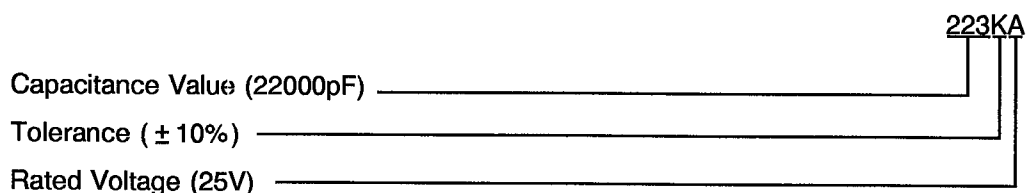


**4.5.3 Electrical Characteristics and Ratings**

The electrical characteristics and ratings to be marked in the following order of precedence are:-

- (a) Capacitance Value.
- (b) Tolerance.
- (c) Rated Voltage.

The information shall be constituted and marked as follows:-



**4.5.3.1 Capacitance Values**

The capacitance values shall be expressed by means of the following codes. The unit quantity for marking shall be picofarads (pF).

CAPACITANCE VALUE	CODE
XX10 <sup>2</sup>	XX2
XX10 <sup>3</sup>	XX3
XX10 <sup>4</sup>	XX4

**4.5.3.2 Tolerances**

The tolerances on capacitance values shall be indicated by the code letters specified hereafter.

TOLERANCE (%)	CODE LETTER
± 5.0	J
± 10	K
± 20	M

**4.5.3.3 Rated Voltage**

The rated voltages shall be indicated by the code letters specified hereafter.

RATED VOLTAGE (U <sub>R</sub> ) (V)	CODE LETTER
25	A
50	C
100	E
200	G
400	K



#### 4.5.4 Traceability Information

Traceability information shall be marked in accordance with the requirements of ESA/SCC Basic Specification No. 21700.

(a) Manufacturing Date Code.

(b) Manufacturer's Name.

#### 4.6 ELECTRICAL MEASUREMENTS

##### 4.6.1 Electrical Measurements at Room Temperature

The parameters to be measured at room temperature are scheduled in Table 2. Unless otherwise specified, the measurements shall be performed at  $T_{amb} = +22 \pm 3$  °C.

##### 4.6.2 Electrical Measurements at High and Low Temperatures

The parameters to be measured at high and low temperatures are scheduled in Table 3.

##### 4.6.3 Circuits for Electrical Measurements

A circuit for use in performing the electrical measurements listed in Table 2 of this specification is shown in ESA/SCC Generic Specification No. 3009.

#### 4.7 BURN-IN TESTS

##### 4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Unless otherwise stated, measurements shall be performed at  $T_{amb} = +22 \pm 3$  °C. The parameter drift values ( $\Delta$ ) applicable to the scheduled parameters shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit value specified in Table 2 shall not be exceeded.

##### 4.7.2 Conditions for Burn-in

The requirements for burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 3009. The conditions for burn-in shall be as specified in Table 5 of this specification.

On completion of burn-in, a recovery period of  $24 \pm 2$  hours is necessary before performance of the end-measurements.

##### 4.7.3 Electrical Circuits for Burn-in (Figure 5)

Not applicable.

**TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE**

No.	CHARACTERISTICS	SYMBOL	ESA/SCC 3009 TEST CONDITIONS	LIMITS		UNIT
				MIN.	MAX.	
1	Capacitance	C	Para. 9.4.1.1	-5.0 -10 -20	+5.0 +10 +20	% (1)
2	Tangent of Loss Angle	$T_{g\delta}$	Para. 9.4.1.2	-	250	$10^{-4}$
3	Insulation Resistance	$R_i$	Para. 9.4.1.3	100 (2)	-	G $\Omega$
4	Voltage Proof	$V_T$	Para. 9.4.1.4	$2.5U_R$	-	V

**NOTES**

- The capacitance limits before burn-in are -5.0 and +20%.
- For C equal to, or less than, 10 000pF.  
For C greater than 10 000pF,  $R_i \times C = 1\ 000$  seconds minimum.

**TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES**

No.	CHARACTERISTICS	SYMBOL	ESA/SCC 3009 TEST CONDITIONS	LIMITS		UNIT	REMARKS
				MIN.	MAX.		
3	Insulation Resistance at $+125 \pm 3^\circ\text{C}$	$R_i$	Para. 9.4.1.3	10 000	-	M $\Omega$	Notes 1, 2 and 4
5(i)	Temperature Characteristic $\frac{\Delta C}{C} = f(T)$	TCC	Para. 9.12 $V_T = 0$ $V_T = U_R$	-20 -30	+20 +20	%	5 parts for each capacitance value. Notes 2 and 5
5(ii)	Temperature Characteristic $\frac{\Delta C}{C} = f(T)$	TCC	Para. 9.12 $V_T = 0$ $V_T = U_R$	-20 -30	+20 +20	%	5 parts for each dielectric lot. Notes 3 and 5

**NOTES**

- Single sample; Inspection Level S3; AQL = 2.5%.
- Applicable to Level 'B' only.
- Applicable to Level 'C' only.
- For C equal to, or less than, 10 000pF;  
For C greater than 10 000pF,  $R_i \times C = 100$  seconds minimum.
- If 1 failure out of 5 parts, then test 100%.  
1.0% rejects maximum allowed in case of 100% testing.

**TABLE 4 - PARAMETER DRIFT VALUES**

No.	CHARACTERISTICS	SYMBOL	SPEC. AND/OR TEST METHOD	TEST CONDITIONS	CHANGE LIMITS ( $\Delta$ )	UNIT
1	Capacitance Change	$\frac{\Delta C}{C}$	ESA/SCC Gen. Spec. 3009	Para's. 9.4.2 and 9.4.1.1	$\pm 15$	%

**FIGURE 4 - TEST CIRCUITS**

Not applicable.

**TABLE 5 - CONDITIONS FOR BURN-IN AND OPERATING LIFE TESTS**

No.	CHARACTERISTIC	SYMBOL	CONDITION	UNIT
1	Ambient Temperature	$T_{amb}$	+ 125	°C
2	Test Voltage	$V_T$	2.0U <sub>R</sub>	V

**FIGURE 5 - ELECTRICAL CIRCUIT FOR BURN-IN AND OPERATING LIFE TESTS**

Not applicable.



- 4.8 ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC GENERIC SPECIFICATION No. 3009)
- 4.8.1 Measurements and Inspections on Completion of Environmental Tests  
The parameters to be measured and inspections to be performed on completion of environmental tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at  $T_{amb} = +22 \pm 3^{\circ}\text{C}$ .
- 4.8.2 Measurements and Inspections at Intermediate Points during Endurance Tests  
The parameters to be measured and inspections to be performed at intermediate points during endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at  $T_{amb} = +22 \pm 3^{\circ}\text{C}$ .
- 4.8.3 Measurements and Inspections on Completion of Endurance Tests  
The parameters to be measured and inspections to be performed on completion of endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at  $T_{amb} = +22 \pm 3^{\circ}\text{C}$ .
- 4.8.4 Conditions for Operating Life Tests (Part of Endurance Testing)  
The requirements for operating life testing are specified in Section 9 of ESA/SCC Generic Specification No. 3009. The conditions for operating life testing shall be as specified in Table 5 for the Burn-in test.
- 4.8.5 Electrical Circuits for Operating Life Tests (Figure 5)  
Not applicable.



**TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING**

NO.	ESA/SCC GENERIC SPECIFICATION NO. 3009		MEASUREMENTS AND INSPECTIONS		SYMBOL	LIMITS		UNIT
	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS		MIN.	MAX.	
01	Mounting	Para. 9.15	<b>Final Examination</b> Terminals <b>Final Measurements</b> Capacitance Tangent of Loss Angle Insulation Resistance	Good Tinning  Table 2 Item 1 Table 2 Item 2 Table 2 Item 3	-  C $T_{g\delta}$ $R_i$	-  Record Values Table 2 Item 2 Table 2 Item 3	-  pF $10^{-4}$ GΩ	
02	Adhesion	Para. 9.5	<b>Final Examination</b> Visual Examination Capacitance	Damage or loosening Table 2 Item 1	-  C	-  Table 2 Item 1	-  pF	
03	Solderability	Para. 9.6	<b>Final Examination</b> Visual Examination	Para. 9.6	-	-	-	
04	Rapid Change of Temperature	Para. 9.7	<b>Initial Measurements</b> Capacitance <b>Final Measurements</b>  Visual Examination Capacitance Change  Tangent of Loss Angle	Table 2 Item 1 Recovery period $24 \pm 2$ hours No damage Table 2 Item 1  Table 2 Item 2	C  - $\frac{\Delta C}{C}$ $T_{g\delta}$	Item 01 Value  - -10 +10  (2)	pF  - % $10^{-4}$	
05	Climatic Test Sequence	Para. 9.8	<b>Initial Measurements</b> Capacitance <b>Final Measurements</b>  Visual Inspection Capacitance Change  Tangent of Loss Angle Insulation Resistance	Table 2 Item 1 Recovery Period 1 -24 hrs Para. 9.8.7 Table 2 Item 1  Table 2 Item 2 Table 2 Item 3	C  - $\frac{\Delta C}{C}$ $T_{g\delta}$ $R_i$	Item 01 Value  - -10 +10  - (2) 3.0(3)	pF  - % $10^{-4}$ GΩ	
06	Damp Heat Steady State	Para. 9.9	<b>Initial Measurements</b> Capacitance <b>Final Measurements</b>  Visual Examination Capacitance Change  Tangent of Loss Angle Insulation Resistance	Table 2 Item 1 Recovery Period 6 - 24 hrs No damage Table 2 Item 1  Table 2 Item 2 Table 2 Item 3	C  - $\frac{\Delta C}{C}$ $T_{g\delta}$ $R_i$	Item 01 Value  - -10 +10  - (2) 3.0(3)	pF  - % $10^{-4}$ GΩ	

**NOTES**

1. The tests in this table refer to either Chart IV or V and shall be used as applicable.
2. Twice the values specified in Table 2 of this specification.
3. Or 30 seconds for  $C > 10\ 000\text{pF}$ .
4. Or 100 seconds for  $C > 10\ 000\text{pF}$ .



**TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (CONT'D)**

NO.	ESA/SCC GENERIC SPECIFICATION NO. 3009		MEASUREMENTS AND INSPECTIONS		SYMBOL	LIMITS		UNIT
	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS		MIN.	MAX.	
07	Operating Life	Para. 9.10	<b>Initial Measurements</b>					
			Capacitance	Table 2 Item 1	C	Item 01 Value	pF	
			<b>Intermediate Measurements</b>	Recovery period 24 ± 2 hours				
			to be performed at 1000 hrs (Chart IV)					
			Capacitance Change	Table 2 Item 1	$\frac{\Delta C}{C}$	-15 +15	%	
			Insulation Resistance	Table 2 Item 3	R <sub>i</sub>	10 (4) -	GΩ	
			<b>Final Measurements</b>	Recovery period 24 ± 2 hours				
			Capacitance Change	Table 2 Item 1	$\frac{\Delta C}{C}$	-15 +15	%	
			Table 2 Item 2	T <sub>gδ</sub>	- (2)	10 <sup>-4</sup>		
			Table 2 Item 3	R <sub>i</sub>	10 (4) -	GΩ		
			Table 2 Item 4	VP	Table 2 Item 4	V		
			Visual Examination	-	-	-		
08	Temperature Characteristic	Para. 9.12	Capacitance Changes	Table 3 Item 5(i) or 5(ii)	TCC	Table 3 Item 5(i) or 5(ii)	%	

**NOTES**

1. The tests in this table refer to either Chart IV or V and shall be used as applicable.
2. Twice the values specified in Table 2 of this specification.
3. Or 30 seconds for C > 10 000pF.
4. Or 100 seconds for C > 10 000pF.





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**APPENDIX 'A'**

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**AGREED DEVIATIONS FOR VITRAMON LTD. (UK)**

ITEMS AFFECTED	DESCRIPTION OF DEVIATIONS
Para. 4.2.1	Microsectioning may be performed using Vitramon document QCN-020 (Issue as per P.I.D.).